



## Description

The AON7410 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

## General Features

$V_{DS} = 30V$   $I_D = 30A$

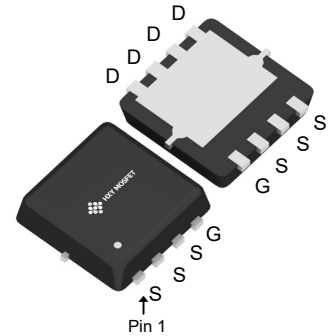
$R_{DS(ON)} < 13m\Omega$  @  $V_{GS}=10V$

## Application

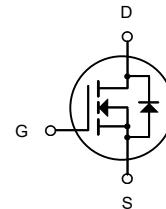
Battery protection

Load switch

Uninterruptible power supply



DFN3X3-8L  
DFN-8(3x3)



N-Channel MOSFET

## Package Marking and Ordering Information

| Product ID | Pack                 | Brand      | Qty(PCS) |
|------------|----------------------|------------|----------|
| AON7410    | DFN3X3-8L/DFN-8(3x3) | HXY MOSFET | 5000     |

## Absolute Maximum Ratings ( $T_C=25^{\circ}C$ unless otherwise noted)

| Symbol                 | Parameter                                             | Rating     | Units         |
|------------------------|-------------------------------------------------------|------------|---------------|
| $V_{DS}$               | Drain-Source Voltage                                  | 30         | V             |
| $V_{GS}$               | Gate-Source Voltage                                   | $\pm 20$   | V             |
| $I_D@T_C=25^{\circ}C$  | Continuous Drain Current, $V_{GS}$ @ 10V <sup>1</sup> | 30         | A             |
| $I_D@T_C=100^{\circ}C$ | Continuous Drain Current, $V_{GS}$ @ 10V <sup>1</sup> | 18         | A             |
| IDM                    | Pulsed Drain Current <sup>2</sup>                     | 55         | A             |
| EAS                    | Single Pulse Avalanche Energy <sup>3</sup>            | 22.1       | mJ            |
| IAS                    | Avalanche Current                                     | 21         | A             |
| $P_D@T_C=25^{\circ}C$  | Total Power Dissipation <sup>4</sup>                  | 20         | W             |
| TSTG                   | Storage Temperature Range                             | -55 to 150 | $^{\circ}C$   |
| $T_J$                  | Operating Junction Temperature Range                  | -55 to 150 | $^{\circ}C$   |
| $R_{\theta JA}$        | Thermal Resistance Junction-ambient <sup>1</sup>      | 75         | $^{\circ}C/W$ |
| $R_{\theta JC}$        | Thermal Resistance Junction-Case <sup>1</sup>         | 6          | $^{\circ}C/W$ |



**Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)**

| Symbol                              | Parameter                                      | Conditions                                                                                 | Min. | Typ.  | Max.  | Unit  |
|-------------------------------------|------------------------------------------------|--------------------------------------------------------------------------------------------|------|-------|-------|-------|
| BV <sub>DSS</sub>                   | Drain-Source Breakdown Voltage                 | V <sub>GS</sub> =0V , I <sub>D</sub> =250uA                                                | 30   | ---   | ---   | V     |
| ΔBV <sub>DSS</sub> /ΔT <sub>J</sub> | BVDSS Temperature Coefficient                  | Reference to 25°C , I <sub>D</sub> =1mA                                                    | ---  | 0.022 | ---   | V/°C  |
| R <sub>DS(ON)</sub>                 | Static Drain-Source On-Resistance <sup>2</sup> | V <sub>GS</sub> =10V , I <sub>D</sub> =10A                                                 | ---  | 8     | 13    | mΩ    |
|                                     |                                                | V <sub>GS</sub> =4.5V , I <sub>D</sub> =5A                                                 | ---  | 12    | 20    |       |
| V <sub>GS(th)</sub>                 | Gate Threshold Voltage                         | V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA                                   | 1.0  | ---   | 2.5   | V     |
| ΔV <sub>GS(th)</sub>                | V <sub>GS(th)</sub> Temperature Coefficient    |                                                                                            | ---  | -5.1  | ---   | mV/°C |
| I <sub>DSS</sub>                    | Drain-Source Leakage Current                   | V <sub>DS</sub> =24V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C                          | ---  | ---   | 1     | uA    |
|                                     |                                                | V <sub>DS</sub> =24V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C                          | ---  | ---   | 5     |       |
| I <sub>GSS</sub>                    | Gate-Source Leakage Current                    | V <sub>GS</sub> =± 20V , V <sub>DS</sub> =0V                                               | ---  | ---   | ± 100 | nA    |
| g <sub>fs</sub>                     | Forward Transconductance                       | V <sub>DS</sub> =5V , I <sub>D</sub> =1A                                                   | ---  | 4.5   | ---   | S     |
| R <sub>g</sub>                      | Gate Resistance                                | V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz                                         | ---  | 2.5   | ---   | Ω     |
| Q <sub>g</sub>                      | Total Gate Charge (4.5V)                       | V <sub>DS</sub> =20V , V <sub>GS</sub> =4.5V , I <sub>D</sub> =10A                         | ---  | 7.2   | ---   | nC    |
| Q <sub>gs</sub>                     | Gate-Source Charge                             |                                                                                            | ---  | 1.4   | ---   |       |
| Q <sub>gd</sub>                     | Gate-Drain Charge                              |                                                                                            | ---  | 2.2   | ---   |       |
| T <sub>d(on)</sub>                  | Turn-On Delay Time                             | V <sub>DD</sub> =12V , V <sub>GS</sub> =10V ,<br>R <sub>G</sub> =3.3<br>I <sub>D</sub> =5A | ---  | 4.1   | ---   | ns    |
| T <sub>r</sub>                      | Rise Time                                      |                                                                                            | ---  | 9.8   | ---   |       |
| T <sub>d(off)</sub>                 | Turn-Off Delay Time                            |                                                                                            | ---  | 15.5  | ---   |       |
| T <sub>f</sub>                      | Fall Time                                      |                                                                                            | ---  | 6.0   | ---   |       |
| C <sub>iss</sub>                    | Input Capacitance                              | V <sub>DS</sub> =15V , V <sub>GS</sub> =0V , f=1MHz                                        | ---  | 572   | ---   | pF    |
| C <sub>oss</sub>                    | Output Capacitance                             |                                                                                            | ---  | 81    | ---   |       |
| C <sub>rss</sub>                    | Reverse Transfer Capacitance                   |                                                                                            | ---  | 65    | ---   |       |
| I <sub>S</sub>                      | Continuous Source Current <sup>1,5</sup>       | V <sub>G</sub> =V <sub>D</sub> =0V , Force Current                                         | ---  | ---   | 28    | A     |
| I <sub>SM</sub>                     | Pulsed Source Current <sup>2,5</sup>           |                                                                                            | ---  | ---   | 55    | A     |
| V <sub>SD</sub>                     | Diode Forward Voltage <sup>2</sup>             | V <sub>GS</sub> =0V , I <sub>S</sub> =1A , T <sub>J</sub> =25°C                            | ---  | ---   | 1.2   | V     |

Note :

- 1.The data tested by surface mounted on a 1 inch<sup>2</sup>FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%
- 3.The EAS data shows Max. rating . The test condition is V<sub>DD</sub>=25V,V<sub>GS</sub>=10V,L=0.1mH,I<sub>AS</sub>=21A
- 4 .The power dissipation is limited by 150°C junction temperature 5.The data is theoretically the same as I<sub>D</sub> and I<sub>DM</sub> , in real applications , should be limited by total power dissipation.



### Typical Characteristics

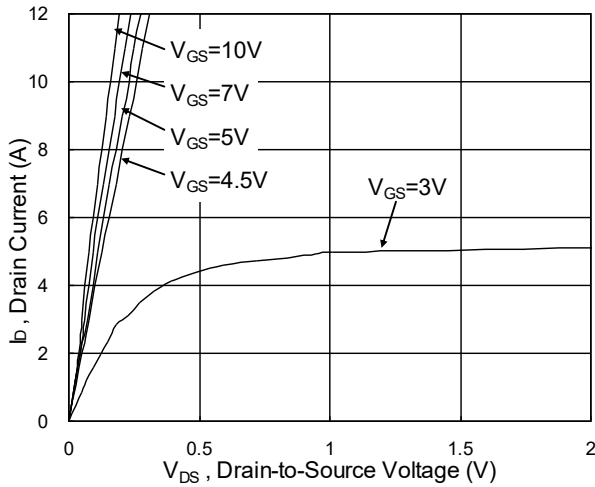


Fig.1 Typical Output Characteristics

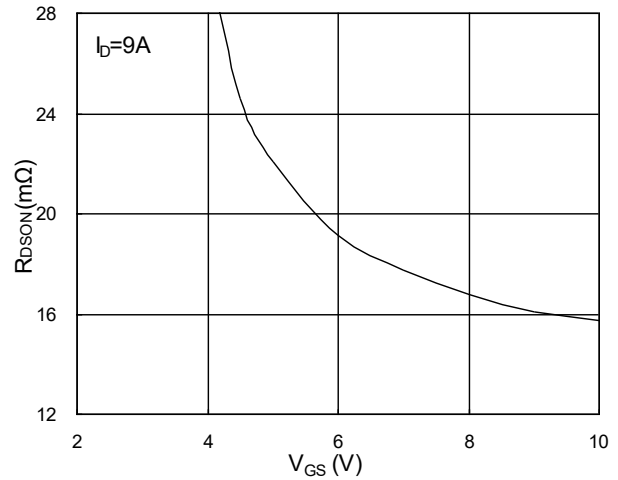


Fig.2 On-Resistance vs. Gate-Source

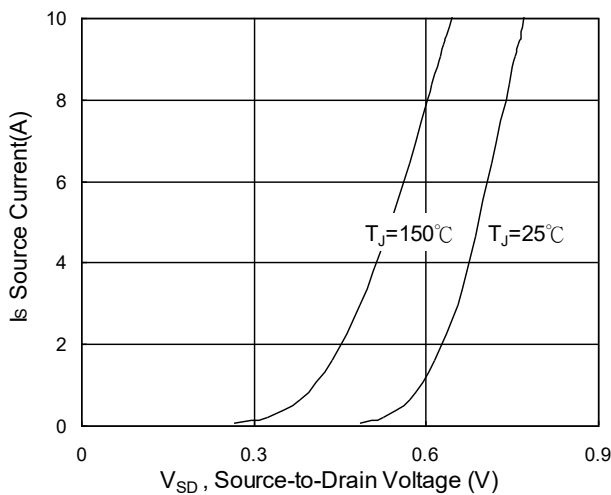


Fig.3 Forward Characteristics Of Reverse

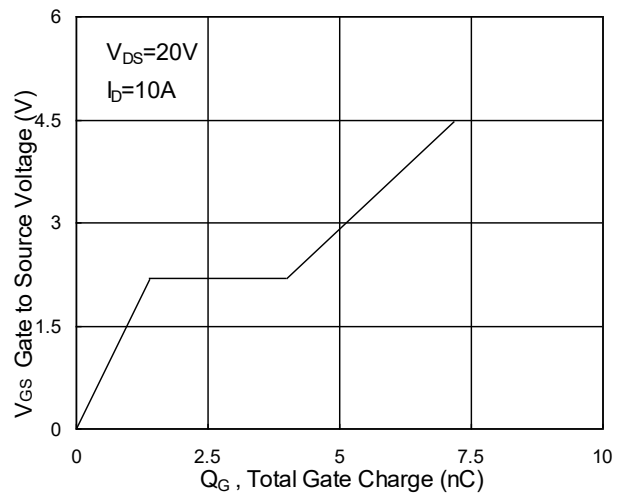


Fig.4 Gate-Charge Characteristics

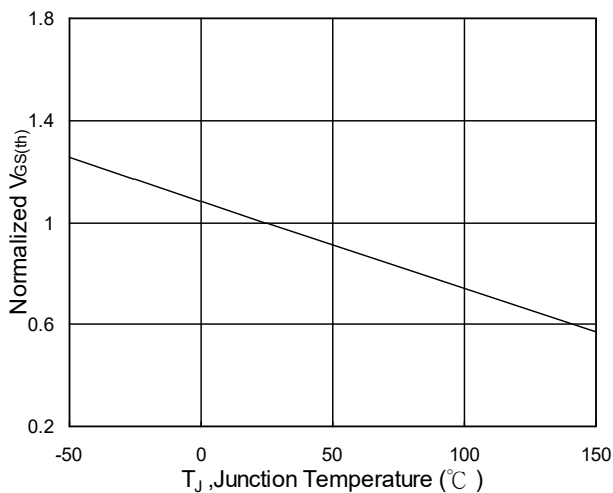


Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$

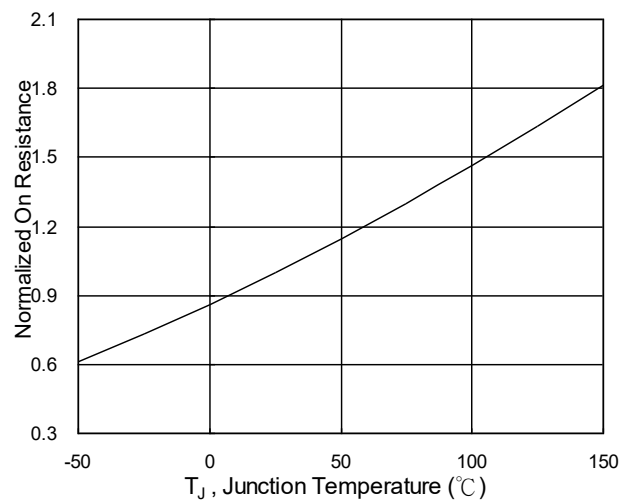


Fig.6 Normalized  $R_{DS(on)}$  vs.  $T_J$

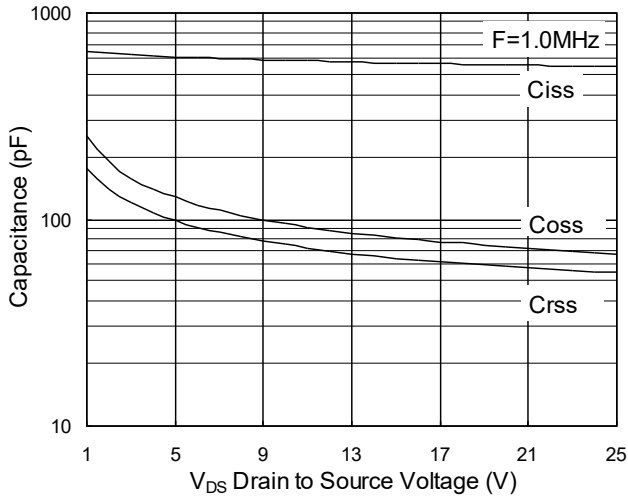


Fig.7 Capacitance

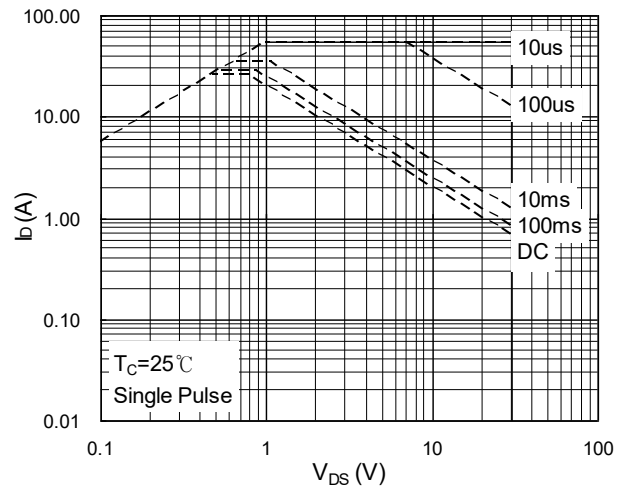


Fig.8 Safe Operating Area

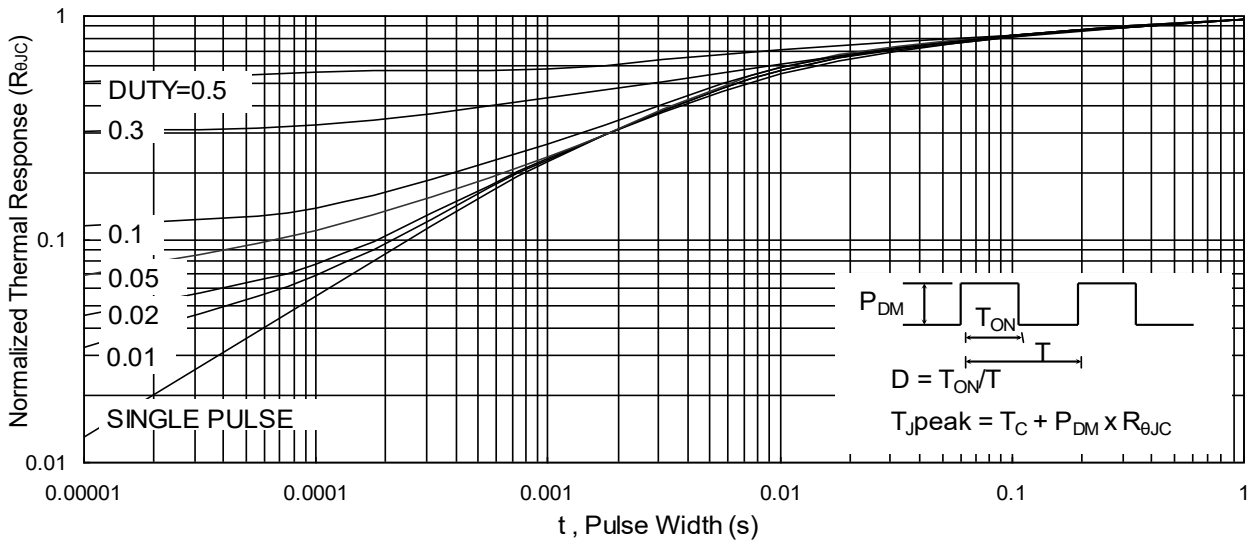


Fig.9 Normalized Maximum Transient Thermal Impedance

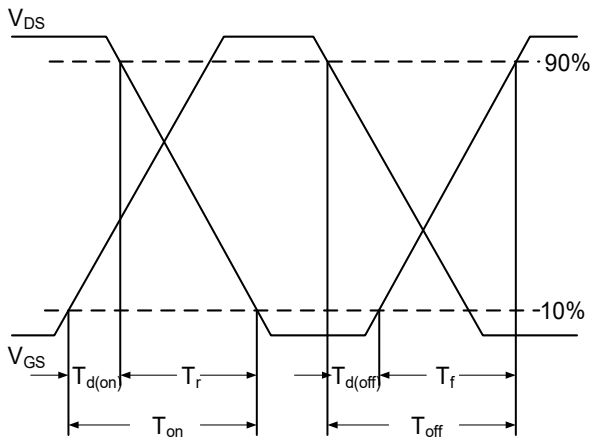


Fig.10 Switching Time Waveform

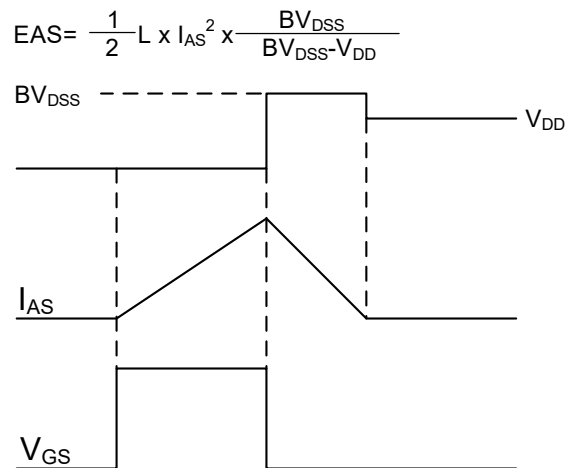


Fig.11 Unclamped Inductive Waveform



## DFN3X3-8L/DFN-8(3x3) Package Information



| Symbol | Dimensions In Millimeters |      |      |
|--------|---------------------------|------|------|
|        | Min.                      | Nom. | Max. |
| A      | 0.70                      | 0.75 | 0.80 |
| b      | 0.25                      | 0.30 | 0.35 |
| c      | 0.10                      | 0.15 | 0.25 |
| D      | 3.25                      | 3.35 | 3.45 |
| D1     | 3.00                      | 3.10 | 3.20 |
| D2     | 1.48                      | 1.58 | 1.68 |
| D3     | -                         | 0.13 | -    |
| E      | 3.20                      | 3.30 | 3.40 |
| E1     | 3.00                      | 3.15 | 3.20 |
| E2     | 2.39                      | 2.49 | 2.59 |
| e      | 0.65BSC                   |      |      |
| H      | 0.30                      | 0.39 | 0.50 |
| L      | 0.30                      | 0.40 | 0.50 |
| L1     | -                         | 0.13 | -    |
| M      | *                         | *    | 0.15 |
| θ      |                           | 10°  | 12°  |



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